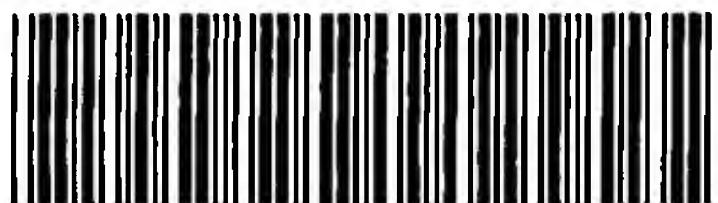


Search Notes**Application/Control No.**

10/709,984

Examiner

Michael P. Choi

Applicant(s)/Patent under Reexamination

LEE, WEN-CHIN

Art Unit

2621

SEARCHED

Class	Subclass	Date	Examiner
386	1,46,52,55	9/25/2007	MC
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386	111-112	9/25/2007	MC
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor Search in eDan	9/20/2007	MC
EAST Search History	9/25/2007	MC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner